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Golden, S.; Friedlander, B.;

 Signal Processing, IEEE Transactions on [see also Acoustics, Speech, and Signal Processing, IEEE Transactions on], Volume: 47, Issue: 6, June 1999
 Pages:1493 - 1501

[\[Abstract\]](#) [\[PDF Full-Text \(204 KB\)\]](#) **IEEE JNL**

2 Density estimation via exponential model selection

Castellan, G.;

Information Theory, IEEE Transactions on, Volume: 49, Issue: 8, Aug. 2003

Pages:2052 - 2060

[\[Abstract\]](#) [\[PDF Full-Text \(596 KB\)\]](#) **IEEE JNL**

3 Estimation and statistical analysis of exponential polynomial signals

Golden, S.; Friedlander, B.;

Signal Processing, IEEE Transactions on [see also Acoustics, Speech, and Signal Processing, IEEE Transactions on], Volume: 46, Issue: 11, Nov. 1998

Pages:3127 - 3130

[\[Abstract\]](#) [\[PDF Full-Text \(144 KB\)\]](#) **IEEE JNL**

4 In-service monitoring for cell loss quality of service violations in ATM networks

Hongbo Zhu; Frost, V.S.;

 Networking, IEEE/ACM Transactions on, Volume: 4, Issue: 2, April 1996
 Pages:240 - 248

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5 Estimation and statistical analysis for exponential polynomial signals

Golden, S.;

 Acoustics, Speech, and Signal Processing, 1995. ICASSP-95., 1995 International Conference on, Volume: 3, 9-12 May 1995
 Pages:1784 - 1787 vol.3

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6 Estimating exponential polynomial signals*Golden, S.; Friedlander, B.;*

Signals, Systems and Computers, 1994. 1994 Conference Record of the
Twenty-Eighth Asilomar Conference on , Volume: 2 , 31 Oct.-2 Nov. 1994
Pages:811 - 815 vol.2

[\[Abstract\]](#) [\[PDF Full-Text \(340 KB\)\]](#) [IEEE CNF](#)

7 Neural algorithms of data performing in finite fields $GF(2^m)$ *Bogatov, V.A.;*

Neuroinformatics and Neurocomputers, 1992., RNNS/IEEE Symposium on
, 7-10 Oct. 1992
Pages:139 - 144 vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(160 KB\)\]](#) [IEEE CNF](#)

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L8	31	integer\$1 and fraction\$2 and 7	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/18 10:32
L9	3	("6289367").URPN.	USPAT	OR	ON	2005/01/18 10:47
L10	5	("5365465" "5642305" "5703801" "5801974" "5831878").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/01/18 10:47
S1	6	"4797807"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/01/14 14:48

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